## Application/Control No. Applicant(s)/Patent Under Reexamination 10/003,703 CHEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2616 Derrick W. Ferris **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,278,693 B1 08-2001 370/252 Aldred et al. Α US-В С US-US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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